



ISO7421E-Q1

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Low-Power Dual Digital Isolators

Check for Samples: ISO7421E-Q1

FEATURES

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- Qualified for Automotive Applications
- AEC-Q100 Qualified with the following results:
 - Device Temperature Grade 1: -40°C to +125°C Ambient Operating Temperature Range
 - Device HBM ESD Classification Level H3A
 - Device CDM ESD Classification Level C4
- Propagation Delay Less Than 20 ns
- Low Power Consumption
- Wide Ambient Temperature: -40°C to 125°C
- Safety and Regulatory Approvals
 - 4 kV peak Maximum Isolation, 2.5 kVrms per UL 1577, IEC/VDE and CSA Approved, IEC 60950-1, IEC 61010-1 End Equipment Standards Approved. All Approvals Pending.
- 50 kV/µs Transient Immunity Typical
- Operates From 3.3 V or 5 V Supply and Logic Levels

APPLICATIONS

- Opto-Coupler Replacement in:
 - Servo Control Interface
 - Motor Control
 - Power Supply
 - Battery Packs

DESCRIPTION

The ISO7421E-Q1 provides double galvanic isolation of up to 2.5 KVrms for 1 minute per UL. This digital isolator has two isolation channels in a bi-directional configuration. Each isolation channel has a logic input and output buffer separated by a silicon oxide (SiO_2) insulation barrier. Used in conjunction with isolated power supplies, these devices prevent noise currents on a data bus or other circuits from entering the local ground and interfering with or damaging sensitive circuitry.

The devices have TTL input thresholds and require two supply voltages, 3.3 V or 5 V, or any combination. All inputs are 5-V tolerant when supplied from a 3.3-V supply.

Note: The ISO7421E-Q1 is specified for signaling rates up to 50 Mbps. Due to their fast response time, under most cases, these devices will also transmit data with much shorter pulse widths. Designers should add external filtering to remove spurious signals with input pulse duration < 20 ns if desired.

ISC	07421E-Q1
GND1 □ 1●	!! 16
NC 🖂 2	¦¦ 15 ── NC
VCC1 🖂 3	14 □ VCC2
OUTA ा 4 -≺	1; ;-{-13 □ INA
INB ¤ 5 – Ĵ	
NC ⊏ 6	ii 11∣⊐⊐ NC
GND1 ा − 7	¦¦ 10 ── NC
NC 🖂 8	9 □ GND2

NC = No Internal Connection



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Table 1. PIN DESCRIPTIONS

	PIN	1/0	DESCRIPTION
NAME	IS07421E-Q1	- I/O	DESCRIPTION
INA	13	I	Input, channel A
INB	5	-	Input, channel B
GND1	1, 7	-	Ground connection for V _{CC1}
GND2	9, 16	0	Ground connection for V _{CC2}
OUTA	4	0	Output, channel A
OUTB	12	-	Output, channel B
V _{CC1}	14	-	Power supply, V _{CC1}
V _{CC2}	14	-	Power supply, V _{CC2}
NC	2, 6, 8, 10, 11, 15		No Connect Pin

DEVICE FUNCTION TABLE

INPUT SIDE (VCC) ⁽¹⁾	OUTPUT SIDE (VCC) ⁽¹⁾	INPUT (IN) ⁽¹⁾	OUTPUT (OUT) ⁽¹⁾
		н	Н
PU	PU	L	L
		Open	Н
PD	PU	X	Н

(1) PU = Powered Up ($V_{CC} \ge 3.15V$); PD = Powered Down ($V_{CC} \le 2.4V$); X = Irrelevant; H = High Level; L = Low Level

AVAILABLE OPTIONS

PRODUCT	RATED T _A	MARKED AS	ORDERING NUMBER
ISO7421E-Q1	–40°C to 125°C	ISO7421EQ	ISO7421EQDWRQ1

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

					VA	LUE	UNIT
					MIN	MAX	
V _{CC}	Supply voltage	⁽²⁾ , V _{CC1} , V _{CC2}			-0.5	6	V
VI	Voltage at IN, 0	tage at IN, OUT				6	V
I _O	Output Current	Output Current				±15	mA
500	Output Current Electrostatic	Human Body Model	AEC-Q100 Classification Level H3A	All		4	kV
ESD	discharge	Charged Device Model	AEC-Q100 Classification Level C4	All pins		1	kV
TJ	Maximum junct	ion temperature				150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values except differential I/O bus voltages are with respect to network ground terminal and are peak voltage values.



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THERMAL INFORMATION

	THERMAL METRIC ⁽¹⁾	ISO7421E-Q1	
		DW (16 Pins)	UNITS
θ_{JA}	Junction-to-ambient thermal resistance	79.9	
θ _{JCtop}	Junction-to-case (top) thermal resistance	44.6	
θ_{JB}	Junction-to-board thermal resistance	51.2	0000
Ψ _{JT}	Junction-to-top characterization parameter	18.0	°C/W
Ψ _{JB}	Junction-to-board characterization parameter	42.2	
θ _{JCbot}	Junction-to-case (bottom) thermal resistance	n/a	
P _D	Device power dissipation, Vcc1 = Vcc2 = 5.25 V, T_J = 150°C, C_L = 15 pF, Input a 0.5 MHz 50% duty cycle square wave	42	mW

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

RECOMMENDED OPERATING CONDITIONS

over operating free-air temperature range (unless otherwise noted)

		MIN	TYP	MAX	UNIT
V _{CC1} , V _{CC2}	Supply voltage - 3.3V Operation	3.15	3.3	3.45	V
	Supply voltage - 5V Operation	4.75	5	5.25	
I _{OH}	High-level output current	-4			mA
I _{OL}	Low-level output current			4	mA
V _{IH}	High-level output voltage	2		V_{CC}	V
V _{IL}	Low-level output voltage	0		0.8	V
T _A	Ambient Temperature	-40		125	°C
T _J ⁽¹⁾	Junction temperature	-40		136	°C
1/t _{ui}	Signaling rate	0		50	Mbps
t _{ui}	Input pulse duration	1			μs

(1) To maintain the recommended operating conditions for T_J, see the *Package Thermal Characteristics* table and the *Icc Equations* section of this data sheet

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ELECTRICAL CHARACTERISTICS

 V_{CC1} and V_{CC2} at 5 V ± 5%, $T_A = -40^{\circ}C$ to 125°C

	PARAMETER	-	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V	High-level output voltage	I _{OH} = -4 mA; S	See Figure 1	V _{CC} –0.8	4.6		V
V _{OH}	High-level output voltage	I _{OH} = -20 μA;	See Figure 1	V _{CC} –0.1	5		v
V		I _{OL} = 4 mA; Se	e Figure 1		0.2	0.4	V
V _{OL}	Low-level output voltage	$\begin{tabular}{ c c c c c c c c c c c c c $	0.1	v			
V _{I(HYS)}	Input threshold voltage hysteresis				400		mV
I _{IH}	High-level input current	Ny at 0 \ ar \	Ny et 0 // er //			10	μA
IIL	Low-level input current		CC	-10			μA
CMTI	Common-mode transient immunity	$V_{I} = V_{CC} \text{ or } 0 $	/; See Figure 3	25	50		kV/µs
SUPPL	Y CURRENT (All inputs switching w	ith square wave	e clock signal for dynamic I _{CC} r	neasurement)			
	ISO7420x						
I _{CC1}	-	DC to 4 Mhrs	DC Input: $V_I = V_{CC}$ or 0 V		0.4	0.8	
I _{CC2}		DC to 1 Mbps	AC Input: C _L = 15 pF		3.4	5	
I _{CC1}					0.6	1	mA
I _{CC2}		10 Mbps			4.5	6	
I _{CC1}	Supply current for V_{CC1} and V_{CC2}				1	1.5	
I _{CC2}		25 Mibps	$C_L = 15 \text{ pr}$		6.2	8	
I _{CC1}					1.7	2.5	
I _{CC2}		50 Maps			9	12	
	ISO7421x						
I _{CC1}		DC to 4 Mhrs	DC Input: $V_I = V_{CC}$ or 0 V		2.3	3.6	
I _{CC2}		DC to 1 Mbps	AC Input: C _L = 15 pF		2.3	3.6	
I _{CC1}		10 Mbpa			2.9	4.5	
I _{CC2}		10 Mbps			2.9	4.5	~ ^
I _{CC1}	Supply current for V_{CC1} and V_{CC2}	OF Mhna			4.3	6	mA
I _{CC2}		25 Mbps	C _L = 15 pF		4.3	6	
I _{CC1}		50 Mhna			6	9.1	
I _{CC2}		50 Mbps			6	9.1	

SWITCHING CHARACTERISTICS

 V_{CC1} and V_{CC2} at 5 V ± 5%, T_A = –40°C to 125°C

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH} , t _{PHL}	Propagation delay time	See Figure 1		9	14	ns
PWD ⁽¹⁾	Pulse width distortion t _{PHL} – t _{PLH}			0.3	3.7	ns
t _{sk(pp)}	Part-to-part skew time				4.9	ns
t _{sk(o)}	Channel-to-channel output skew time				3.6	ns
t _r	Output signal rise time	See Figure 1		1		ns
t _f	Output signal fall time			1		ns
t _{fs}	Fail-safe output delay time from input power loss	See Figure 2		6		μs



ELECTRICAL CHARACTERISTICS

 V_{CC1} at 5 V ± 5%, V_{CC2} at 3.3 V ± 5%, $T_A = -40^{\circ}$ C to 105°C

	PARAMETER	Т	EST CONDITIONS	MIN	TYP	MAX	UNIT
		I _{OH} = -4 mA;	5-V side	V _{CC} –0.8	4.6		
V _{OH}	High-level output voltage	See Figure 1	3.3-V side	V _{CC} –0.4	3		V
		I _{OH} = -20 μA; See	See Figure 1	V _{CC} –0.1	V _{CC}		
V _{OL} Low-level output voltage	I _{OL} = 4 mA; Se	e Figure 1		0.2	0.4		
VOL	Low-level output voltage	I _{OL} = 20 μA; Se	e Figure 1		0	0.1	V
V _{I(HYS)}	Input threshold voltage hysteresis				400		mV
I _{IH}	High-level input current					10	μA
IIL	Low-level input current	INx at 0 V or V	CC	-10			μA
CMTI	Common-mode transient immunity	$V_{I} = V_{CC} \text{ or } 0 V$; See Figure 3	25	40		kV/μs
SUPPL	Y CURRENT (All inputs switching w	vith square wave	e clock signal for dynamic I _{CC}	measurement)			
	ISO7420x						
I _{CC1}	_	DC to 1 Mbpo	DC Input: $V_I = V_{CC}$ or 0 V		0.4	0.8	
I _{CC2}		DC to 1 Mbps	AC Input: $C_L = 15 \text{ pF}$		2.6	3.7	
I _{CC1}		10 Mbm			0.6	1	
I _{CC2}		10 Mbps			3.3	4.3	
I _{CC1}	Supply current for V_{CC1} and V_{CC2}				1	1.5	mA
I _{CC2}		25 Mbps	C _L = 15 pF		4.4	5.6	
I _{CC1}		50 Mhrs			1.7	2.5	
I _{CC2}		50 Mbps			6.2	7.5	
	IS07421x						
I _{CC1}		DC to 1 Mbro	DC Input: $V_I = V_{CC}$ or 0 V		2.3	3.6	
I _{CC2}		DC to 1 Mbps	AC Input: C _L = 15 pF		1.8	2.8	
I _{CC1}		10 Mbpo			2.9	4.5	
I _{CC2}		10 Mbps			2.2	3.2	~ ^
I _{CC1}	Supply current for V_{CC1} and V_{CC2}	25 Mbpo	0 15 5		4.3	6	mA
I _{CC2}		25 Mbps	C _L = 15 pF		2.8	4.1	
I _{CC1}		EQ Mbra			6	9.1	
I _{CC2}	7	50 Mbps			3.8	5.8	

SWITCHING CHARACTERISTICS

 V_{CC1} at 5 V ± 5%, V_{CC2} at 3.3 V ± 5%, T_A = –40°C to 125°C

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH} , t _{PHL}	Propagation delay time	See Figure 1		10	17	ns
PWD ⁽¹⁾	Pulse width distortion t _{PHL} – t _{PLH}			0.5	5.6	ns
t _{sk(pp)}	Part-to-part skew time				6.3	ns
t _{sk(o)}	Channel-to-channel output skew time				4	ns
t _r	Output signal rise time	See Figure 1		2		ns
t _f	Output signal fall time			2		ns
t _{fs}	Fail-safe output delay time from input power loss	See Figure 2		6		μs

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ELECTRICAL CHARACTERISTICS

 V_{CC1} at 3.3 V ± 5%, V_{CC2} at 5 V ± 5%, $T_A = -40^{\circ}$ C to 125°C

	PARAMETER	т	EST CONDITIONS	MIN	TYP	MAX	UNIT
/ _{OH} High-level output voltage		I _{OH} = -4 mA;	5-V side	V _{CC} –0.8	4.6		
V _{OH}	High-level output voltage	See Figure 1	3.3-V side	V _{CC} -0.4	3		V
		I _{OH} = -20 μA; S	See Figure 1	V _{CC} -0.1	V _{CC}	0.4 0.1 10 0.4 5 0.6 6 0.9 8 1.3 12 2.8 3.6 3.2 4.5 4.1	
V		I _{OL} = 4 mA; See	e Figure 1		0.2	0.4	V
V _{OL}	Low-level output voltage	I _{OL} = 20 μA; Se	e Figure 1		0	0.1	v
V _{I(HYS)}	Input threshold voltage hysteresis				400		mV
I _{IH}	High-level input current	Ny at 0 V ar V				10	μA
IIL	Low-level input current	INx at 0 V or V ₀	C	-10			μA
CMTI	Common-mode transient immunity	$V_{I} = V_{CC} \text{ or } 0 V$; See Figure 3	25	40		kV/µs
SUPPL	Y CURRENT (All inputs switching w	ith square wave	clock signal for dynamic I _{CC}	measurement)			
	ISO7420x						
I _{CC1}		DC to 1 Mbps	DC Input: $V_I = V_{CC}$ or 0 V		0.2	0.4	
I _{CC2}	-		AC Input: $C_L = 15 \text{ pF}$		3.4	5	
I _{CC1}		10 Mbps	 С _L = 15 рF		0.4	0.6	mA
I _{CC2}	Supply current for V_{CC1} and V_{CC2}				4.5	6	
I _{CC1}		25 Mbps			0.6	0.9	
I _{CC2}		25 10005			6.2	8	
I _{CC1}		50 Mbps			1	1.3	
I _{CC2}		50 Mbps			9	12	
	ISO7421x						
I _{CC1}		DC to 1 Mbps	DC Input: $V_I = V_{CC}$ or 0 V		1.8	2.8	
I _{CC2}		DC to 1 Mbps	AC Input: $C_L = 15 \text{ pF}$		2.3	3.6	
I _{CC1}		10 Mbps			2.2	3.2	
I _{CC2}	Supply current for V_{CC1} and V_{CC2}				2.9	4.5	m۵
I _{CC1}		25 Mbps	C _L = 15 pF		2.8	4.1	mA
I _{CC2}					4.3	6	
I _{CC1}		50 Mbps			3.8	5.8	
I _{CC2}		50 Mups			6	9.1	

SWITCHING CHARACTERISTICS

 V_{CC1} at 3.3 V ± 5%, V_{CC2} at 5 V ± 5%, T_A = –40°C to 125°C

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH} , t _{PHL}	Propagation delay time	See Figure 1		10	17	ns
PWD ⁽¹⁾	Pulse width distortion t _{PHL} – t _{PLH}			0.5	4	ns
t _{sk(pp)}	Part-to-part skew time				8.5	ns
t _{sk(o)}	Channel-to-channel output skew time				4	ns
t _r	Output signal rise time	See Figure 1		2		ns
t _f	Output signal fall time			2		ns
t _{fs}	Fail-safe output delay time from input power loss	See Figure 2		6		μs

ELECTRICAL CHARACTERISTICS

 V_{CC1} and V_{CC2} at 3.3 V ± 5%, $T_{A} = -40^{\circ}$ C to 125°C

	PARAMETER	-	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V		I _{OH} = -4 mA; S	See Figure 1	V _{CC} -0.4	3		V
V _{OH}	High-level output voltage	I _{OH} = -20 μA;	See Figure 1	V _{CC} –0.1	3.3		v
		I _{OL} = 4 mA; Se	e Figure 1		0.2	0.4	V
V _{OL}	Low-level output voltage	I _{OL} = 20 μA; Se	ee Figure 1		0	0.1	V
V _{I(HYS)}	Input threshold voltage hysteresis				400		mV
I _{IH}	High-level input current	INty at 0 \ (ar)	1				μA
IIL	Low-level input current	INx at 0 V or V	СС	-10			μA
CMTI	Common-mode transient immunity	$V_{I} = V_{CC} \text{ or } 0 $	/; See Figure 3	25	40		kV/µs
SUPPL	Y CURRENT (All inputs switching w	ith square wave	e clock signal for dynamic I _{CC} m	neasurement)			
	ISO7420x						
I _{CC1}		DC to 1 Mhno	DC Input: $V_I = V_{CC}$ or 0 V		0.2	0.4	
I _{CC2}	_	DC to 1 Mbps	AC Input: C _L = 15 pF		2.6	3.7	
I _{CC1}					0.4	0.6	
I _{CC2}	Supply surrent for V and V	10 Mbps			3.3	4.3	mA
I _{CC1}	Supply current for V_{CC1} and V_{CC2}	05 Miles -	C _L = 15 pF		0.6	0.9	
I _{CC2}		25 Mbps	$G_L = 15 \text{ pr}$		4.4	5.6	
I _{CC1}		50 Mbps			1	1.3	
I _{CC2}		50 Mibps			6.2	7.5	
	ISO7421x						
I _{CC1}		DC to 1 Mhno	DC Input: $V_I = V_{CC}$ or 0 V		1.8	2.8	
I _{CC2}		DC to 1 Mbps	AC Input: $C_L = 15 \text{ pF}$		1.8	2.8	
I _{CC1}		10 Mbps			2.2	3.2	
I _{CC2}	Supply current for Variand V				2.2	3.2	mA
I _{CC1}	Supply current for V_{CC1} and V_{CC2}	25 Mbps	C _L = 15 pF		2.8	4.1	mA
I _{CC2}		25 iviops			2.8	4.1	
I _{CC1}		EQ Mbpa			3.8	5.8	
I _{CC2}		50 Mbps		3.8	5.8		

SWITCHING CHARACTERISTICS

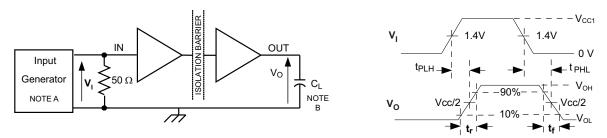
 V_{CC1} and V_{CC2} at 3.3 V ± 5%, T_A = –40°C to 125°C

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH} , t _{PHL}	Propagation delay time	See Figure 1		12	20	ns
PWD ⁽¹⁾	Pulse width distortion t _{PHL} – t _{PLH}			1	5	ns
t _{sk(pp)}	Part-to-part skew time				6.8	ns
t _{sk(o)}	Channel-to-channel output skew time				5.5	ns
t _r	Output signal rise time	See Figure 1		2		ns
t _f	Output signal fall time			2		ns
t _{fs}	Fail-safe output delay time from input power loss	See Figure 2		6		μs

NSTRUMENTS

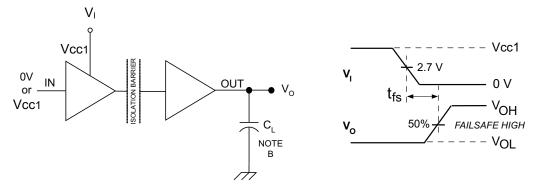
EXAS

PARAMETER MEASUREMENT INFORMATION



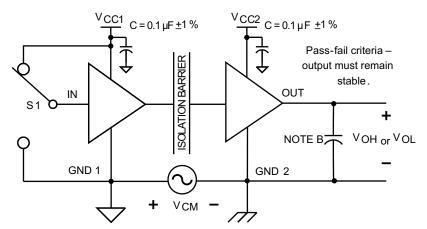
- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 50 kHz, 50% duty cycle, t_r \leq 3ns, t_f \leq 3ns, Z_O = 50 Ω .
- B. $C_L = 15 \text{ pF}$ and includes instrumentation and fixture capacitance within ±20%.

Figure 1. Switching Characteristic Test Circuit and Voltage Waveforms



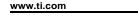
A. $C_L = 15 \text{ pF}$ and includes instrumentation and fixture capacitance within ±20%.

Figure 2. Failsafe Delay Time Test Circuit and Voltage Waveforms



A. $C_L = 15 \text{ pF}$ and includes instrumentation and fixture capacitance within ±20%.

Figure 3. Common-Mode Transient Immunity Test Circuit



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STRUMENTS

DEVICE INFORMATION

PACKAGE CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
L(I01)	Minimum air gap (Clearance)	Shortest terminal to terminal distance through air	8.34			mm
L(102)	Minimum external tracking (Creepage)	Shortest terminal to terminal distance across the package surface	8.1			mm
СТІ	Tracking resistance (Comparative Tracking Index)	DIN IEC 60112 / VDE 0303 Part 1	≥400			V
	Minimum internal gap (Internal Clearance)	Distance through the insulation	0.014			mm
R _{IO}	Isolation resistance, input to output ⁽¹⁾	Input to output, V_{IO} = 500 V, all pins on each side of the barrier tied together creating a two-terminal device		>10 ¹²		Ω
CIO	Barrier capacitance input to output ⁽¹⁾	$V_{IO} = 0.4 \sin(2\pi ft), f = 1 MHz$		2		pF
CI	Input capacitance to ground ⁽²⁾	$V_1 = V_{CC}/2 + 0.4 \sin(2\pi ft), f = 1 \text{ MHz}, V_{CC} = 5 \text{ V}$		2		pF

(1) All pins on each side of the barrier tied together creating a two-terminal device.

(2) Measured from input pin to ground.

NOTE

Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed circuit board do not reduce this distance

Creepage and clearance on a printed circuit board become equal according to the measurement techniques shown in the Isolation Glossary. Techniques such as inserting grooves and/or ribs on a printed circuit board are used to help increase these specifications.

IEC 60664-1 RATINGS TABLE

PARAMETER	TEST CONDITIONS	SPECIFICATION
Basic Isolation Group	Material Group	II
	Rated mains voltages <= 150 Vrms	I - IV
Installation Classification	Rated mains voltages <= 300 Vrms	I - IV
	Rated mains voltages <= 400 Vrms	I - III

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NSTRUMENTS

EXAS

INSULATION CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	SPECIFICATION	UNIT	
VIORM	Maximum working insulation voltage		1414	Vpeak	
		Method a, After environmental tests subgroup 1, $V_{PR} = V_{IORM} \times 1.6$, t = 10 s, Partial discharge < 5 pC	2262		
V _{PR}	Input to output test voltage	Method b1, $V_{PR} = V_{IORM} \times 1.875$, t = 1 s (100% Production test) Partial discharge < 5 pC	2651	Vpeak	
		After Input/Output Safety Test Subgroup 2/3, $V_{PR} = V_{IORM} \times 1.2$, t = 10 s, Partial discharge < 5 pC	1697		
V _{IOTM}	Transient overvoltage	t = 60 sec (qualification)	4242	Vpeak	
M		$V_{\text{TEST}} = V_{\text{ISO}}, t = 60 \text{ sec (qualification)}$	2500) (maging	
V _{ISO}	Isolation voltage per UL	t = 1 sec (100% production)	3000	Vrms	
R _S	Insulation resistance	V _{TEST} = 500 V at T _S = 150°C	>10 ⁹	Ω	
	Pollution degree		2		

REGULATORY INFORMATION

VDE	CSA	UL
Certified according to IEC 60747-5-2	Approved under CSA Component Acceptance Notice	Recognized under 1577 Component Recognition Program
File Number: pending	File Number: pending	File Number: E181974

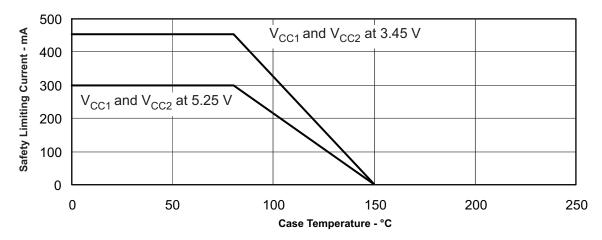
IEC SAFETY LIMITING VALUES

Safety limiting intends to prevent potential damage to the isolation barrier upon failure of input or output circuitry. A failure of the IO can allow low resistance to ground or the supply and, without current limiting, dissipate sufficient power to overheat the die and damage the isolation barrier potentially leading to secondary system failures.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
la.	Cofety input output or output outpot	$\theta_{JA} = 212^{\circ}C/W, V_{I} = 5.5 V, T_{J} = 170^{\circ}C, T_{A} = 25^{\circ}C$			112	~ ^
IS	Safety input, output, or supply current	$\theta_{JA} = 212^{\circ}C/W, V_{I} = 3.6 V, T_{J} = 170^{\circ}C, T_{A} = 25^{\circ}C$			171	mA
Ts	Maximum Case Temperature				150	°C

The safety-limiting constraint is the absolute maximum junction temperature specified in the absolute maximum ratings table. The power dissipation and junction-to-air thermal impedance of the device installed in the application hardware determines the junction temperature. The assumed junction-to-air thermal resistance in the Thermal Characteristics table is that of a device installed on a High-K Test Board for Leaded Surface Mount Packages. The power is the recommended maximum input voltage times the current. The junction temperature is then the ambient temperature plus the power times the junction-to-air thermal resistance.







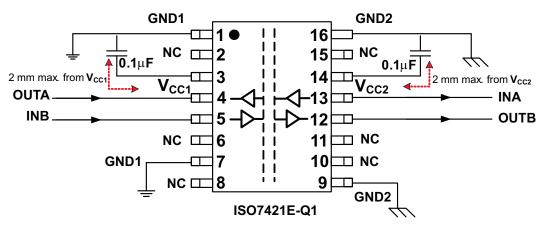


Figure 5. Typical ISO7421E-Q1 Application Circuit

EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS

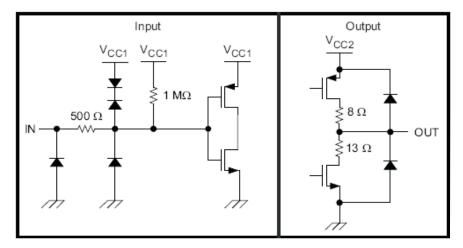
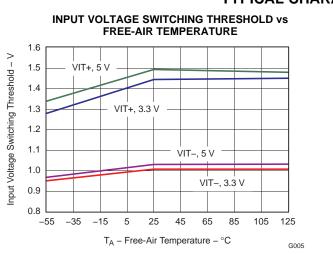
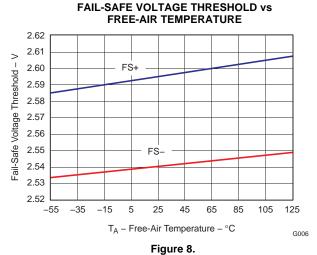


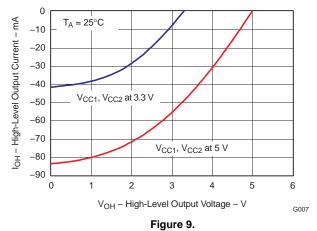
Figure 6. I/O Schematic



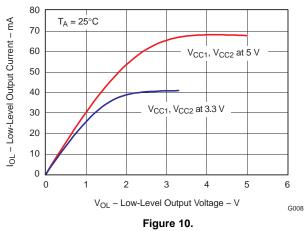




HIGH-LEVEL OUTPUT CURRENT vs HIGH-LEVEL OUTPUT VOLTAGE



LOW-LEVEL OUTPUT CURRENT vs LOW-LEVEL OUTPUT VOLTAGE



TYPICAL CHARACTERISTICS

EXAS NSTRUMENTS

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REVISION HISTORY

Cł	hanges from Revision A (March 2012) to Revision B	Page
•	Changed signaling rate info from 1 to 50 Mbps.	1
•	Changed Signaling rate max value from 1 to 50 Mbps, centered 0 in the min column.	3
•	Replaced Supply Current section with marked up table from commercial datasheet SLLSE45, changed 8.5 max value to 9.1.	4
•	Replaced Supply Current section with marked up table from commercial datasheet SLLSE45, changed 8.5 max value to 9.1 and changed 5.5 max value to 5.8.	5
•	Replaced Supply Current section with marked up table from commercial datasheet SLLSE45, changed 5.5 max value to 5.8 and changed 8.5 max value to 9.1.	6
•	Replaced Supply Current section with marked up table from commercial datasheet SLLSE45, changed 5.5 max value to 5.8.	7



PACKAGING INFORMATION

Orderable Device	ce Status ⁽¹⁾ Package T		Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
ISO7421EQDWRQ1	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF ISO7421E-Q1 :

Catalog: ISO7421E

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION

REEL DIMENSIONS

TEXAS INSTRUMENTS





TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

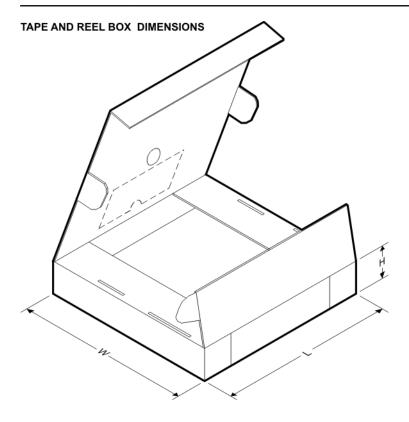
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO7421EQDWRQ1	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

8-Aug-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO7421EQDWRQ1	SOIC	DW	16	2000	533.4	186.0	36.0

DW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AA.



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